

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination JEONG, HOON	
		Examiner Kevin Quarterman	Art Unit 2879	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,841,927 B2	01-2005	Lee, Tae Hoon	313/474
	B	US-2003/0222562 A1	12-2003	Jeon et al.	313/402
	C	US-6,774,553 B2	08-2004	Pyun et al.	313/477R
	D	US-6,690,106 B1	02-2004	Yoshida et al.	313/461
	E	US-6,528,935 B1	03-2003	Wakasono et al.	313/461
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.